

Notice of References Cited	Application/Control No. 10/761,080	Applicant(s)/Patent Under Reexamination BEAUCHAMP, PHILLIP J.	
	Examiner Binh X. Tran	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0179193	09-2004	Maezono et al.	356/239.1
*	B	US-5,756,885	05-1998	Poku et al.	73/104
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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